Power MOSFETS

DATASHEET

LM30100PAK8A

P-Channel

Enhancement Mode MOSFET

Leadpower-semiconductor Corp., Ltd

sales@leadpower-semi.com

(03) 6577339 FAX：(03) 6577229

www.leadpower-semi.com

Quality Management Systems

ISO 9001:2015 Certificate

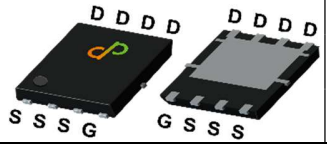
LM30100PAK8A

P-Channel Enhancement Mode MOSFET

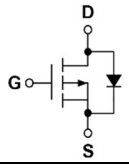
Pin Description

PDFN5*6

Top View Bottom View



Symbol



Ordering Information

Symbol	P-Channel	Unit
V_{DSS}	-30	V
$R_{DS(ON)-Max}$	11.2	mΩ
I_D	-70	A

Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested

Applications

- Portable Equipment
- Battery Powered System

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM30100PAK8A	PDFN5*6	Tape & Reel	5000 / Tape & Reel	30100 □□□□□□

Note：□□□□□□ = Lot Code

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter		P-Channel	Unit
V_{DSS}	Drain-Source Voltage		-30	V
V_{GSS}	Gate-Source Voltage		±20	
T_J	Maximum Junction Temperature		150	°C
T_{STG}	Storage Temperature Range		-55 to 150	°C
I_{DM}①	Pulse Drain Current Tested	T_C=25°C	-70	A
I_D	Continuous Drain Current	T_C=25°C	-53	A
		T_C=100°C	-33	
P_D	Maximum Power Dissipation	T_C=25°C	46	W
		T_C=100°C	19	
I_{AS}②	Avalanche Current, Single pulse	L=0.1mH	-35	A
E_{AS}②	Avalanche Energy, Single pulse	L=0.1mH	61	mJ

Thermal Characteristics

Symbol	Parameter		Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	2.7	°C/W
$R_{\theta JA}$③	Thermal Resistance-Junction to Ambient	Steady State	50	°C/W

Note ①：Max. current is limited by bonding wire
Note ②：UIS tested and pulse width are limited by maximum junction temperature 150°C
Note ③：Surface Mounted on 1in^2 FR-4 board with

P-Channel Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_{DS}=-250uA	-30	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=-24V, V_{GS}=0V	-	-	-1	uA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_{DS}=-250uA	-1	-1.5	-2	V
I_{GSS}	Gate Leakage Current	V_{GS}=±20V, V_{DS}=0V	-	-	±100	nA
$R_{DS(ON)}$④	Drain-Source On-state Resistance	V_{GS}=-10V, I_{DS}=-13A	-	9.3	11.2	mΩ
		V_{GS}=-4.5V, I_{DS}=-9A	-	12.2	16	
gfs	Forward Transconductance	V_{DS}=-5V, I_{DS}=-13A	-	25	-	S
Dynamic Characteristics ⑤						
R_G	Gate Resistance	V_{GS}=0V,V_{DS}=0V, Freq.=1MHz	-	6.6	-	Ω
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=-15V, Freq.=1MHz	-	2828	-	pF
C_{oss}	Output Capacitance		-	343	-	
C_{rss}	Reverse Transfer Capacitance		-	291	-	
$td_{(ON)}$	Turn-on Delay Time	V_{GS}=-10V,V_{DS}=-15V, I_D=-1A,R_{GEN}=2.7Ω	-	11.4	-	nS
t_r	Turn-on Rise Time		-	24	-	
$t_{d(OFF)}$	Turn-off Delay Time		-	104	-	
t_f	Turn-off Fall Time		-	56.8	-	
Q_g	Total Gate Charge	V_{GS}=-4.5V,V_{DS}=-15V I_D=-13A	-	33	-	nC
Q_g	Total Gate Charge	V_{GS}=-10V,V_{DS}=-15V, I_D=-13A	-	65	-	
Qgs	Gate-Source Charge		-	8.7	-	
Qgd	Gate-Drain Charge		-	15	-	
Source-Drain Characteristics						
V_{SD}④	Diode Forward Voltage	I_{SD}=-3A, V_{GS}=0V	-	-0.75	-1.1	V
t_{rr}	Reverse Recovery Time	I_F=-20A, V_R=-15V dI$_F$/dt=100A/μs	-	15.6	-	nS
Q_{rr}	Reverse Recovery Charge		-	8	-	nC

Note ④：Pulse test (pulse width≤300us, duty cycle≤2%).
Note ⑤：Guaranteed by design, not subject to production testing.

P-Channel Typical Characteristics

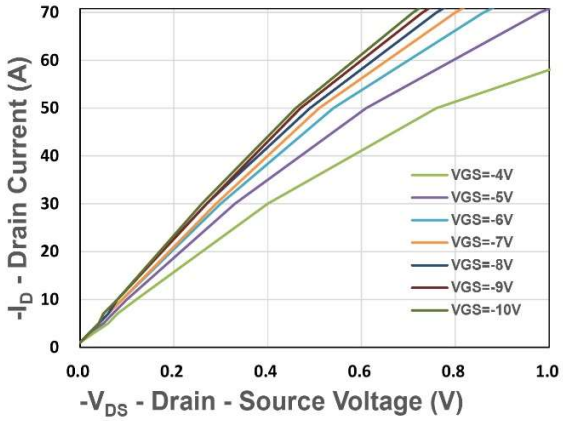


Figure 1. Output Characteristics

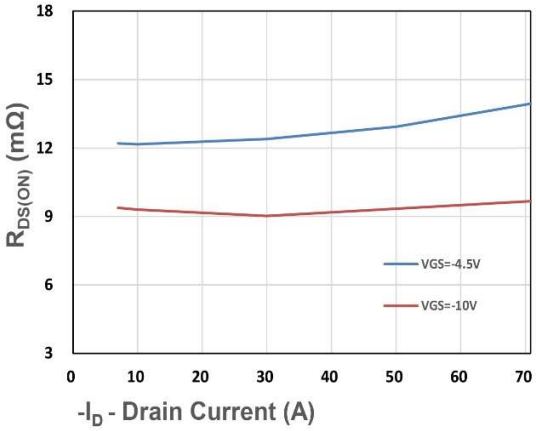


Figure 2. On-Resistance vs. ID

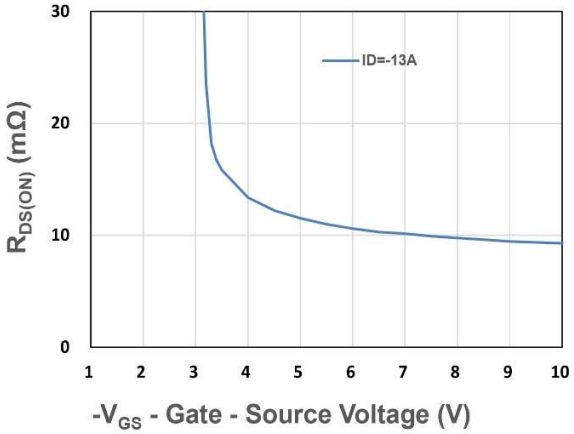


Figure 3. On-Resistance vs. VGS

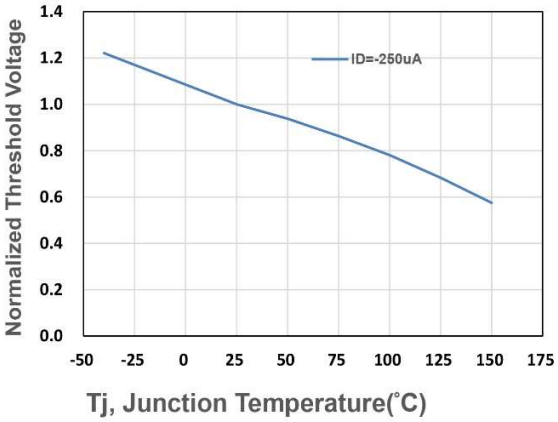


Figure 4. Gate Threshold Voltage

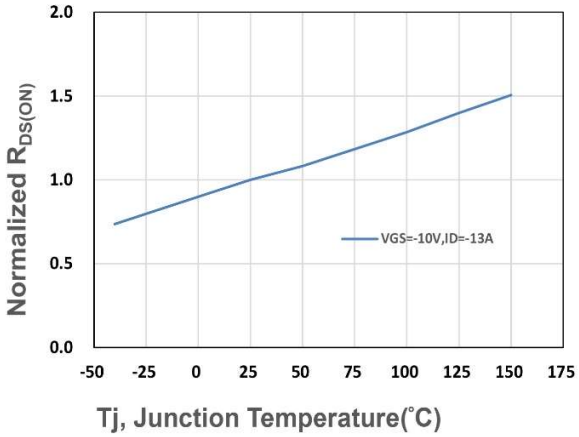


Figure 5. Drain-Source On Resistance

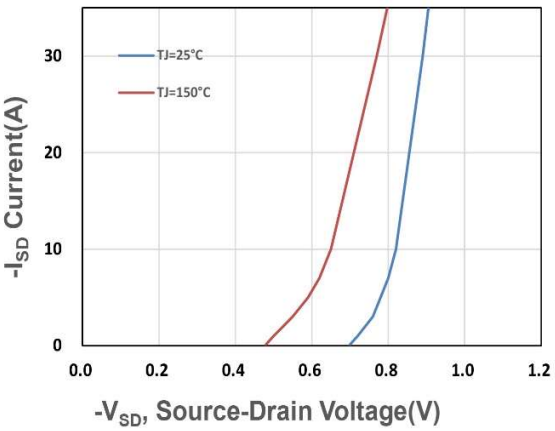


Figure 6. Source-Drain Diode Forward

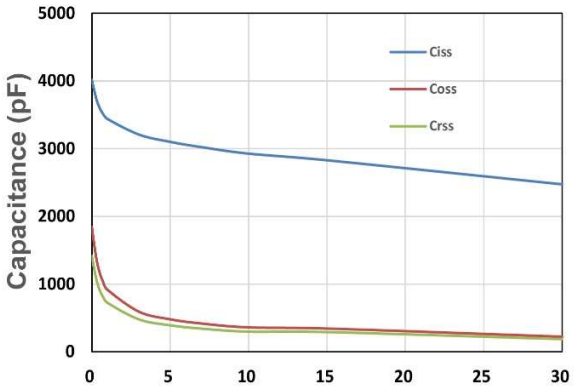


Figure 7. Capacitance

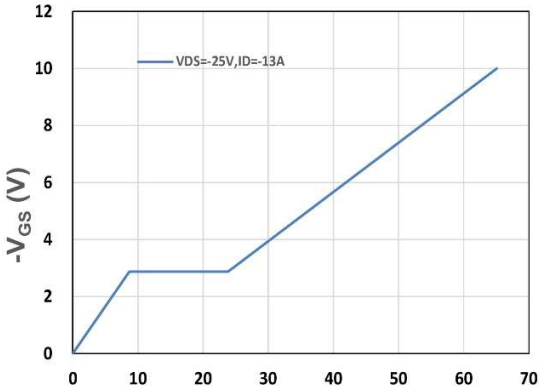


Figure 8. Gate Charge Characteristics

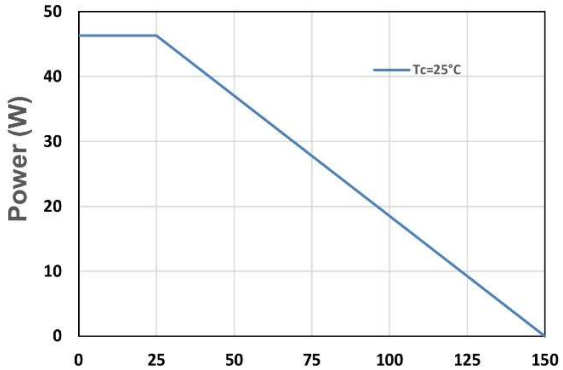


Figure 9. Power Dissipation

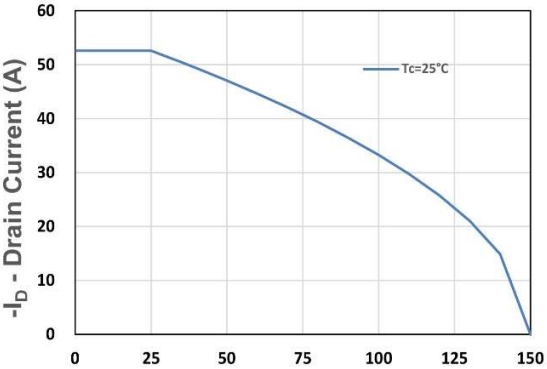


Figure 10. Drain Current

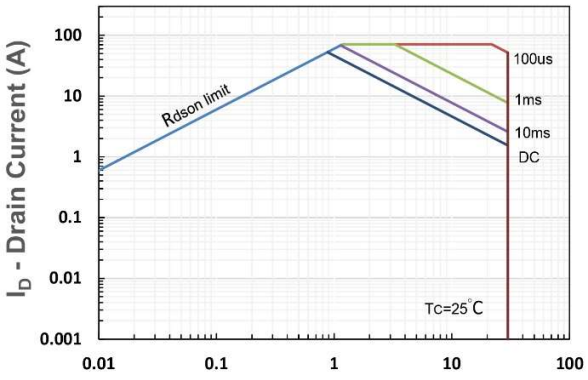


Figure 11. Safe Operating Area

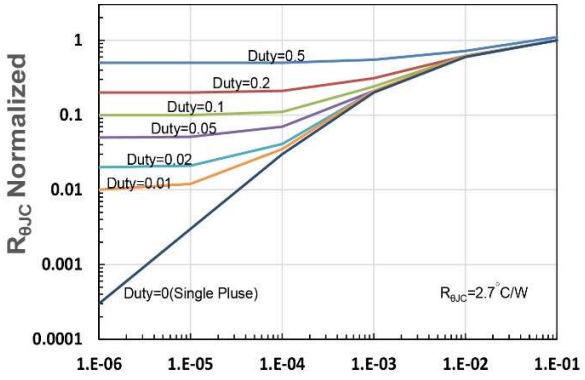


Figure 12. RθJC Transient Thermal Impedance